

Search Notes



Application/Control No.

09/474,909

Examiner

Tan Dean D. Nguyen

Applicant(s)/Patent under Reexamination

MARRY ET AL.

Art Unit

3629

SEARCHED

Class	Subclass	Date	Examiner
705	400	2002 03 04 05 2/20/06	DN
	402		
	406		
	410		
364	401		
	406		
	408		
209	584		
	900		
700	30		
	400		

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

SEARCH NOTES (INCLUDING SEARCH STRATEGY)

	DATE	EXMR
	10/2000 2001 2002 2004 2/20/06	DN
I US		
Patent PG Pub		
II FOREIGN		
1. EPO 2. JPO 3. Derwent		
III NPL (Dialogs)		
1. Ftext1 2. Ftext2 3. NFFext 2 (NFFext)		
* Reviewing 09/474,908 or US 6,508,365		
• No ODP rejection required since claimed inventions are different.		